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FORM PTO-1449 (Modified) LIST OF PATENTS AND PUBLICATIONS FOR 5 2002				ATTY. DOCKET NO. IFIS920030375			SERIAL NO. 10/709,239		
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REFERENCE	DESIGNATION	U.S.	PATE	NT DOCUMENTS					
EXAMINER INITIALS	DOCUMENT NUMBER	DATE		NAME		CLASS	SUBCLA	FILING DATE (IF APPRO.)	
CAL	6,228,694 B1	5/8/2001		Doyle et al.					
	6,406,973 B1	6/18/2002		Lee					
	6,281,532 B1	8/28/2001		Doyle et al.					
	5,683,934	11/4/97		Candelaria					
	6,368,931 B1	4/9/2002		Kuhn, et al.					
	5,310,446	5/10/94		Konishi et al.					
	4,853,076	8/1/89		Tsaur et al.					
	UŚ 2002/0090791 A1	7/11/2002		Doyle et al.				·	
	US 2002/0074598 A1	6/20/2002		Doyle et al.					
	6,509,618 B2	1/21/2003		Jan et al.					
	6,476,462 B2	11/5/2002		Shimizu et al.					
	6,362,082 B1	3/26/2002		Doyle et al.		•			
	6,228,694 B1	5/8/2001		Doyle et al.					
	5,565,697	10/15/96		Asakawa et al.					
	US 2003/0040158 A1	2/27/2003		Saitoh					
	US 2002/0086472 A1	7/4/2002		Roberds et al.		•			
V	6,521,964 B1	2/18/2003		Jan et al.				1 .	
Car	6,506,652	01/14/03		Jan, et al.					
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EXAMINER INITIALS	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLA		NG DATE APPRO.)
CAL	5,081,513	1/14/1992		Jackson, et al.		:		
	3,602,841	8/31/1971		McGroddy				
	6,531,740	3/11/2003		Bosco, et al.				
	6,531,369	3/11/2003		Ozkan, et al.	1	- 		
	6,501,121	12/31/2002		Yu, et al.			 	
	6,498,358	12/24/2002		Lach, et al.				
	6,493,497	12/10/2002	1	Ramdani, et al.	 		╅──	
	6,403,975	6/11/2002	1	Brunner, et al.			1-	
	6,361,885	3/26/2002	 	Chou	-	 	-	
	6,255,169	7/3/2001	<u> </u>	Li, et al.			 	·
	6,246,095	6/12/2001		Brady, et al.	 		┪	
	6,165,383	12/26/2000		Chou	+		 	
/	6,133,071	10/17/2000		Nagai			 	
	6,046,464	4/4/2000		Schetzina	1	 	 	•
CAL	6,025,280	2/15/2000		Brady, et al.	 		1	-
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CAL	5,940,736	8/17/1999		Brady, et al.		1	<u></u>	<u> </u>	
	5,880,040	3/9/1999		Sun, et al.			_		
	5,861,651	1/19/1999		Brasen, et al.				·	
	5,679,965	10/21/1997		Schetzina			-		
	5,670,798	9/23/1997		Schetzina	- 				
	5,561,302	10/1/1996		Candelaria	- 	 			
	5,471,948	12/5/1995		Burroughes, et al.					
	5,459,346	10/17/1995		Asakawa, et al.			- -		
	5,391,510	2/21/1995		Hsu, et al.	-		1		
	5,371,399	12/6/1994		Burroughes, et al.		+	 		
	5,108,843	4/28/1992		Ohtaka, et al.	 		+		
	5,060,030	10/22/1991		Hoke	-		+		
į	4,958,213	9/18/1990		Eklund, et al.	 		-		
V	4,665,415	5/12/1987		Esaki, et al.	 		 		
CAV	6,635,506	10/21/2003		Volant et al.			-		
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EXAMINER DOCUMENT NUMBER		DATE		NAME	CLASS	SUBCLAS	FILING DATI		
CAN	5,989,978	11/23/1999		Peidous					
	6,284,626	9/4/2001		Kim					
	6,274,444	8/14/2001		Wang					
	6,261,964	7/17/2001		Wu, et al.					
	6,221,735	4/24/2001		Manley, et al.					
	6,117,722	9/12/2000		Wuu, et al.					
	6,107,143	8/22/2000		Park, et al.	4				
	6,090,684	7/18/2000		Ishitsuka, et al.					
	6,066,545	5/23/2000		Doshi, et al.					
·	6,008,126	12/28/1999		Leedy					
	5,946,559	8/31/1999	•	Leedy					
	5,840,593	11/24/1998		Leedy					
	5,592,018	1/7/1997		Leedy					
V	5,592,007	1/7/1997		Leedy					
M	5,571,741	11/5/1996		Leedy					
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COL	5,557,122	9/17/1996	Shrivastava, et al.					
	5,354,695	10/11/1994	Leedy	·				
	5,134,085	7/28/1992	Gilgen, et al.					
	5,006,913	4/9/1991	Sugahara, et al.					
	4,952,524	8/28/1990	Lee, et al.					
	4,855,245	8/8/1989	Neppl, et al.					
	2002/0086497	07-04-2002	Kwok					
	5,960,297	09-28-1999	Saki					
	6,403,486	06-11-2002	Lou					
	6,284,623	09-04-2001	Zhang et al.		(
	2003/0032261	02-13-2003	Yeh et al.					
	2003/0057184	03-27-2003	Yuetal					
	6,265,317	07-24-2001	Chiu et al.					
	2003/0067035	04-10-2003	Tews et al.					
	6,461,936	10-08-2002	von Ehrenwali					
1/	6,319,794	11-20-2001	Akatsu et al.					
V	2001/0009784	07-26-2001	Ma et al.	·				
CAU	6,621,392	09-16-2003	Volant et al.					
		FOREIC	GN PATENT DOCUME	NTS				
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Application Number Docket Number (Optional) FORM PTO-1449 (Modified) FIS920030375 10/709,239 LIST OF PATENTS AND PUBLICATIONS Applicant(s) Hullong Zhu, et al. FOR APPLICANT'S INFORMATION Filing Date Group Art Unit DISCLOSURE STATEMENT 4/23/04 2811 **U.S. PATENT DOCUMENTS** *EXAMINER DOCUMENT NUMBER DATE FILING DATE NAME SUDCLASS INITIAL IF APPROPRIATE 5,940,716 8/17/1999 Jin, et al. FOREIGNPATENT DOCUMENTS REF DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS YES NO OTHER DOCUMENTS (Including Author, Tide, Date, Pertinent Pages, Etc.)

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Supplemental FORM PTO-1449 (Modified)			ATTY. DOCKET NO. FIS9200303		SERIAL NO. 10/709,239			
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CAL	Kem Rim, et al., International Elec	Transconductance I tron Devices Meetin	Enhancement in Deep S g, 26, 8, 1, IEEE, Septe	Submicron S mber 1998	Strained-Si <i>n-</i> M	OSFETs",		
			Device Design of Sub-1 y Digest of Technical Pr			PMOSFETs",		
	Gregory Scott, et Isolation Induced	al., "NMOS Drive Co Stress", Internationa	rrent Reduction Cause il Electron Devices Mee	d by Transi ting, 34.4.1	stor Layout and , IEEE, Septem	Trench iber 1999.		
	F. Ootsuka, et al., "A Highly Dense, High-Performance 130nm node CMOS Technology for Large Scale System-on-a-Chip Application", International Electron Devices Meeting, 23.5.1, IEEE, April 2000.							
1	Shinya Ito, et al., ' Transistor Design	Mechanical Stress I , International Elect	Effect of Etch-Stop Nitric ron Devices Meeting, 10	de and its lo 0.7.1, IEEE	npact on Deep , April 2000.	Submicron		
V	A. Shimizu, et al., Enhancement', In	*Local Mechanical- ternational Electron	Stress Control (LMC): A Devices Meeting, IEEE,	New Techi March 200	nique for CMOS)1.	-Performance		
CAV			Channel Technique for I g, 2.2.1, IEEE, February		mance 55nm C	MOS",		
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